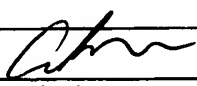


Form PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. 65,716-077		SERIAL NO. Herewith 10/190514						
				APPLICANT: TURNER, et al.								
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				FILING DATE February 27, 2004		GROUP: unknown 2636						
U.S. PATENT DOCUMENTS												
Examiner Initial	Document No.							Date	Name	Class	Sub- Class	Filing Date
HCL	2	0	3	5	2	1	8	3/24/36	Bloom	229	71	7/26/32
	4	1	0	3	4	4	4	08/01/78	Jones et al.	40	124.1	12/27/76
	4	2	9	9	0	4	1	11/10/81	Wilson	40	124.1	09/20/79
	4	4	2	6	0	3	5	1/17/84	Dieckow	206	526	3/10/81
	4	6	0	7	7	4	7	8/26/86	Steiner	206	232	2/4/85
	4	6	1	1	2	6	2	9/9/86	Galloway et al.	361	421	05/11/84
	4	8	6	5	2	4	7	9/12/89	Grabner	229	92.1	3/15/88
	4	8	6	6	8	6	5	9/19/89	Yang	40	455	2/8/88
	5	0	3	0	1	8	9	7/9/91	Hightower	493	186	12/27/89
	5	0	4	5	0	4	0	9/3/91	Vetter	493	194	3/28/90
	5	2	4	5	1	7	1	9/14/93	Fox et al.	235	492	7/27/90
	5	2	9	0	2	2	5	3/1/94	Younger	493	188	4/29/92
	5	9	8	6	5	6	9	11/16/99	Mish et al.	340	825.54	3/20/97
	5	9	9	5	0	0	6	11/30/99	Walsh	340	572.7	1/15/96
	6	1	7	3	5	5	4	1/16/01	Marbler	53	412	2/19/99
	6	4	6	9	6	2	7	10/22/02	Forster	340	572.8	2/11/00
FOREIGN PATENT DOCUMENTS												
Examiner Initial	Document No.							Date	Country	Class	Sub- Class	Filing Date
OTHER DOCUMENTS (Incl. Author, Title, Date, Pertinent Pages, etc.)												
Examiner 									Date Considered 8/16/05			
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		APPLICANT: TURNER, et al.				
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		FILING DATE February 27, 2004		GROUP: unknown 636		
U.S. PATENT DOCUMENTS						
Examiner Initial	Document No.	Date	Name	Class	Sub- Class	Filing Date
hal	2002 00 3 6 2 3 7	3/28/02	Atherton et al.	235	492	7/26/01
	2002 00 4 4 0 5 8	4/18/02	Heinrich et al.	340	572.1	8/14/01
	2002 00 6 7 2 6 4	6/6/02	Soehnlen	340	572.1	3/15/01
	2002 00 6 7 2 6 6	6/6/02	Lee et al.	340	572.7	12/1/00
	2002 00 6 7 2 6 8	6/6/02	Lee et al.	340	572.7	8/10/01
	2002 01 9 5 1 9 5	12/26/02	Grabau et al.	156	300	7/29/02
	2003 01 5 6 0 3 3	8/21/03	Savage et al.	340	572.8	1/14/02
	2003 00 1 6 1 2 2	1/23/03	Petrack	340	10.41	7/19/01
	2003 01 8 9 4 9 0	10/9/03	Hogerton et al.	340	572.8	4/3/02
	2003 01 9 7 0 6 4	10/23/03	Saint et al.	235	492	4/19/02
FOREIGN PATENT DOCUMENTS						
Examiner Initial	Document No.	Date	Country	Class	Sub- Class	Filing Date
OTHER DOCUMENTS (Incl. Author, Title, Date, Pertinent Pages, etc.)						
hal	RFID A Key to Automating Everything, by Roy Want, Scientific American, Pages 54-65, January 2004					
Examiner			Date Considered 8/16/05			
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